

Search Notes

Application/Control No.

10/799,786

Examiner

Erin D. Chiem

Applicant(s)/Patent under
Reexamination

NAKANO ET AL.

Art Unit

2883

SEARCHED

Class	Subclass	Date	Examiner

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
385/14,15.ccls. and text search	1/4/05	EDC